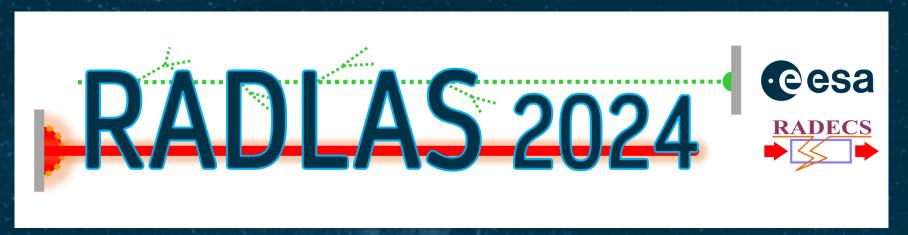


Welcome to



6th Workshop on Laser Testing of Radiation Effects on Components and Systems

<u>Ali Zadeh</u> - Head of the Data Systems, Microelectronics and Component Technology Division

Thomas Borel - Component Test Engineer

ESA ESTEC 11/09/2024

ESA UNCLASSIFIED – For ESA Official Use Only



RADLAS 2024







6th Workshop on Laser Testing of Radiation Effects on Components and Systems

ESA - European Space research and TEchnology Centre (ESTEC)

The only workshop mainly focussing on laser testing of EEE

Previous Editions

- RALFDAY 2007
- RALFDAY 2009
- RADLAS 2011
- RADLAS 2013
- RADLAS 2017 Montpellier (7 years ago!)

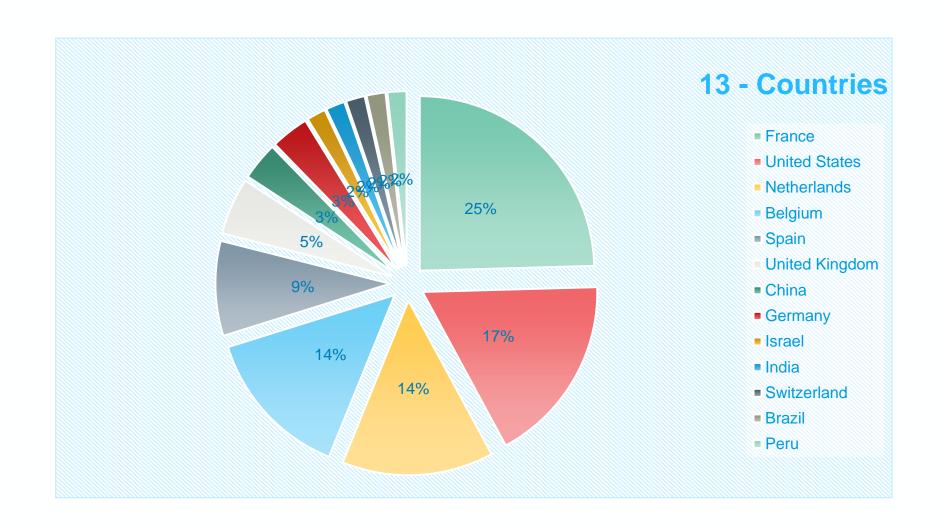


Technical Committee:

Christian Poivey, ESA
Dale McMorrow, NRL
Florent Miller, Nucletudes
Thomas Borel, ESA
Vincent Pouget, UM - CNRS

Participants





Laser in ESA (ESTEC)









Starting point

- Laser SEE test methods utilised for research as well as industrial purposes
- ESA has been following the Laser SEE test approaches closely for years
- In 2021 ESA acquired an SPA and TPA Laser test system



Why Laser SEE testing

- Alternative test method, that can generate charges in a similar way as HI
- Screening and Validation
- Cost Effective
- Alleviate Heavy ion Facility unavailability



Approach

- Predominantly R&D activities but also project support
 - TDE: Single-Event Effects Testing with a Laser Beam Guidelines (available)
 - TDE: Radiation Testing of Several COTS Parts to be Used as Protection Devices
 - TDE: Investigation on intra-die variability and radiation-induced SEL in a COTS SRAM memory flying on Proba-V
 - OSIP: Adoption of SEE laser testing as part of the RHA process for COTS screening and validation



Main Objectives

- (1) Increase competency and knowledge of **SEE Laser Test Systems**
- Work towards more cost-effective Radiation Hardness Assurance processes



Correlation to Heavy Ions data not straight forward



Perspective with Pulse Laser testing







Laser Testing Guidelines:



US: Pulsed-Laser Single-Event Effects Testing - A Practical Desk Reference (2023)

For now, pulse laser testing is promising system for:

- a) Screening of COTS component (before mainly HI test campaign)
- b) Lot to lot variability
- c) Failure analysis design verification / radiation hardening
- d) Calibration of radiation monitors
- e) Research

Laser SEE Testing is an important tool in our toolbox More R&D Activities are being proposed and initiated

Workshop format





Invited Talk

- "Basics and definitions for Laser Testing of Single-Event Effects", Vincent Pouget
- "Historical look at the Development of the Focused, Pulsed Laser for SEE Testing of Integrated Circuits", **Stephen Buchner** (Remotely)

Sessions:

- Recent test results (5 presentations)
- Test Methodology for SEE Laser Testing (2 presentations)
- Comparison between Laser and Heavy Ions (6 presentations)

Posters during Coffee break (3 Posters)

Round Table

Visit of the Materials & Electrical Components Laboratory (For registered person only)





About RADLAS

Schedule Morning







09:00	Coffee			
	Newton 2, ESA-ESTEC	09:00 - 09:30		
	1 - RADLAS 2024 - Opening	All Zadejj		
	27 - Invited Talk: Basics and definitions for Laser Testing of Single-Event Effects	Vincent POUGET		
10:00	Newton 2, ESA-ESTEC	09:40 - 10:10 _{,d}		
	2 - Session: Recent Laser test results			
11:00	Newton 2, ESA-ESTEC	10:10 - 11:10 _d		
11.00	Coffee Break	7 - Poster		
	Newton 2, ESA-ESTEC 11:10 - 11	40 Newton 2, ESA-ESTEC 11:10 - 11:40 _a		
	2 - Session: Recent Laser test results	11.10-11.40		
12:00	Newton 2, ESA-ESTEC	11:40 - 12:20 _d		
	3 - Session: Test Methodology for SEE Laser Testing			
	Newton 2, ESA-ESTEC	12:20 - 13:00 _d		
13:00	Lunch Break			
14:00				
	Newton 2, ESA-ESTEC	13:00 - 14:20		
		8		

Schedule Afternoon





→ THE EUROPEAN SPACE AGENCY

13:00	Lunch Break		
14:00			-
	Newton 2, ESA-ESTEC		13:00 - 14:20
	20 - Invited Talk: Historical look at the Development of the Focused, Pulsed Laser for SEE Testing of Integrated Circuits		Steve Buchner
	Newton 2, ESA-ESTEC		14:20 - 15:00,
15:00	4 - Session: Comparison between Laser and Heavy Ions		
	Newton 2, ESA-ESTEC		15:00 - 16:00,
16:00	Coffee Break	7 - Poster	
	Newton 2, ESA-ESTEC 16:00 - 16:30	Newton 2, ESA-ESTEC	16:00 - 16:30,
	4 - Session: Comparison between Laser and Heavy Ions		
17:00			_
	Newton 2, ESA-ESTEC		16:30 - 17:30 _#
	5 - Round Table		10.30 - 17.30
	o Notific Nation		
18:00			
18.00			
	Newton 2, ESA-ESTEC		17:30 - 18:30 _d

Posters



Three Posters

- "Nonlinear Multiphoton Absorption Of Silicon Carbide And Gallium Nitride Photodiodes In Near-Infrared Spectrum"
 - Presenter: Chris CHONG (Radtest Ltd)
- "Towards Laser Testing of FinFET Devices: Lessons Learnt from Planar Technologies"
 - Presenter: Maxim GORBUNOV (IMEC)
- "Towards a Laser to Beam SEE/SEL Estimation Methodology"
 - Presenter: Ricardo ASCAZUBI (Intel Corp.)

Wi-Fi Access







Wi-Fi In Your badge



Welcome to the RADLAS 2024

To access the ESA Wireless network please connect to the network with the following settings:

SSID: esa-public

Authentication: Open

Then open a web browser. You will be automatically re-directed to the appropriate login page, where you can enter the credentials. Please note that the SSID name is case-sensitive (lower case).

«User» «Psw»

Note: Please note that the SSID name, user, password are case-sensitive (all lower case)

ESTEC Site



- Coffee Corner
 - -07:30-17:00
- Restaurant
 - 11:30 14:00
- ESTEC Shop
 - -10:00-16:00
- Space EXPO
 - -10:00-17:00
- ESCAPE
 - -17:00-22:00

